

Notice of References Cited	Application/Control No. 10/786,622	Applicant(s)/Patent Under Reexamination INOUE ET AL.	
	Examiner Mei Q. Huang	Art Unit 1713	Page 1 of 1

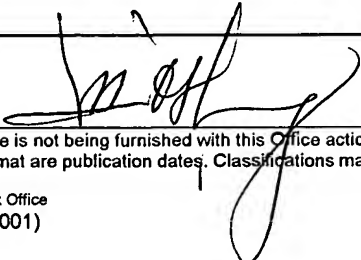
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*	A	US-4,419,134	12-1983	Ishijima et al.	106/642
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NON-PATENT DOCUMENTS

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*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
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